BS EN 61000-4-4:2004 +A1:2010

Incorporating corrigenda August 2006 and June 2007

Electromagnetic compatibility (EMC) —

Part 4-4: Testing and measurement techniques — Electrical fast transient/burst immunity test

ICS 33.100.20



National foreword

This British Standard is the UK implementation of EN 61000-4-4:2004+A1:2010. It is identical to IEC 61000-4-4:2004, incorporating amendment 1:2010, and corrigenda August 2006 and June 2007. It supersedes BS EN 61000-4-4:2004 which will be withdrawn on March 2013.

The UK participation in its preparation was entrusted by Technical Committee GEL/210, EMC — Policy committee, to Subcommittee GEL/210/12, EMC basic, generic and low frequency phenomena standardization.

A list of organizations represented on this subcommittee can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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This British Standard was published under the authority of the Standards Policy and Strategy Committee on 2 February 2005

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English version

Electromagnetic compatibility (EMC) Part 4-4: Testing and measurement techniques Electrical fast transient/burst immunity test

(IEC 61000-4-4:2004)

Compatibilité électromagnétique (CEM) Partie 4-4: Techniques d'essai et de mesure -Essais d'immunité aux transitoires électriques rapides en salves (CEI 61000-4-4:2004) Elektromagnetische Verträglichkeit (EMV) Teil 4-4: Prüf- und Messverfahren -Prüfung der Störfestigkeit gegen schnelle transiente elektrische Störgrößen/Burst (IEC 61000-4-4:2004)

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CENELEC

European Committee for Electrotechnical Standardization Comité Européen de Normalisation Electrotechnique Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

BŠ EN 61000-4-4:2004+A1:2010 EN 61000-4-4:2004+A1:2010

Foreword

The text of document 77B/419/FDIS, future edition 2 of IEC 61000-4-4, prepared by SC 77B, High frequency phenomena, of IEC TC 77, Electromagnetic compatibility, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61000-4-4 on 2004-10-01.

This European Standard supersedes EN 61000-4-4:1995 + A1:2001 + A2:2001.

This new edition improves and clarifies simulator specifications, test criteria and test set-ups. Only common mode injection is required.

The following dates were fixed:

 latest date by which the EN has to be implemented at national level by publication of an identical national standard or by endorsement

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(dow) 2007-10-01

Annex ZA has been added by CENELEC.

Endorsement notice

The text of the International Standard IEC 61000-4-4:2004 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following note has to be added for the standard indicated:

IEC 61000-4-4 NOTE Harmonized as EN 61000-4-4:1995 (not modified).

Foreword to amendment A1

The text of document 77B/621/FDIS, future amendment 1 to IEC 61000-4-4:2004, prepared by SC 77B, High frequency phenomena, of IEC TC 77, Electromagnetic compatibility, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as amendment A1 to EN 61000-4-4:2004 on 2010-03-01.

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The following dates were fixed:

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Endorsement notice

The text of amendment 1:2010 to the International Standard IEC 61000-4-4:2004 was approved by CENELEC as an amendment to the European Standard without any modification.

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INTRODUCTION

IEC 61000 is published in separate parts, according to the following structure:

Part 1: General

General considerations (introduction, fundamental principles)

Definitions, terminology

Part 2: Environment

Description of the environment

Classification of the environment

Compatibility levels

Part 3: Limits

Emission limits

Immunity limits (in so far as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques

Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines

Mitigation methods and devices

Part 6: Generic standards

Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as international standards or as technical specifications or technical reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and a second number identifying the subdivision (example: 61000-6-1).

This part is an international standard which gives immunity requirements and test procedures related to electrical fast transients/bursts.

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ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-4: Testing and measurement techniques – Electrical fast transient/burst immunity test

1 Scope

This part of IEC 61000-4 relates to the immunity of electrical and electronic equipment to repetitive electrical fast transients. It gives immunity requirements and test procedures related to electrical fast transients/bursts. It additionally defines ranges of test levels and establishes test procedures.

The object of this standard is to establish a common and reproducible reference for evaluating the immunity of electrical and electronic equipment when subjected to electrical fast transient/bursts on supply, signal, control and earth ports. The test method documented in this part of IEC 61000-4 describes a consistent method to assess the immunity of an equipment or system against a defined phenomenon.

NOTE As described in IEC Guide 107, this is a basic EMC publication for use by product committees of the IEC. As also stated in Guide 107, the IEC product committees are responsible for determining whether this immunity test standard should be applied or not, and if applied, they are responsible for determining the appropriate test levels and performance criteria. TC 77 and its sub-committees are prepared to co-operate with product committees in the evaluation of the value of particular immunity tests for their products.

The standard defines:

- test voltage waveform;
- range of test levels;
- test equipment;
- verification procedures of test equipment;
- test set-up;
- test procedure.

The standard gives specifications for laboratory and post-installation tests.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050-161:1990, International Electrotechnical Vocabulary (IEV) – Chapter 161: Electromagnetic compatibility

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3 Terms and definitions

For the purposes of this document, the following terms and definitions, together with those in IEC 60050-161 apply.

NOTE Several of the most relevant terms and definitions from IEC 60050-161 are presented among the definitions below.

3.1

burst

sequence of a limited number of distinct pulses or an oscillation of limited duration

[IEV 161-02-07]

3.2

calibration

set of operations which establishes, by reference to standards, the relationship which exists, under specified conditions, between an indication and a result of a measurement

NOTE 1 This term is based on the "uncertainty" approach.

NOTE 2 The relationship between the indications and the results of measurement can be expressed, in principle, by a calibration diagram.

[IEV 311-01-09]

3.3

coupling

interaction between circuits, transferring energy from one circuit to another

3.4

common mode (coupling)

simultaneous coupling to all lines versus the ground reference plane

3.5

coupling clamp

device of defined dimensions and characteristics for common mode coupling of the disturbance signal to the circuit under test without any galvanic connection to it

3.6

coupling network

electrical circuit for the purpose of transferring energy from one circuit to another

3.7

decoupling network

electrical circuit for the purpose of preventing EFT voltage applied to the EUT from affecting other devices, equipment or systems which are not under test

3.8

degradation (of performance)

undesired departure in the operational performance of any device, equipment or system from its intended performance

NOTE The term "degradation" can apply to temporary or permanent failure.

[IEV 161-01-19]

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3.9

EFT/B

electrical fast transient/burst

3.10

electromagnetic compatibility (EMC)

ability of an equipment or system to function satisfactorily in its electromagnetic environment without introducing intolerable electromagnetic disturbances to anything in that environment

[IEV 161-01-07]

3.11

EUT

equipment under test

3.12

ground reference plane

flat conductive surface whose potential is used as a common reference

[IEV 161-04-36]

3.13

immunity (to a disturbance)

ability of a device, equipment or system to perform without degradation in the presence of an electromagnetic disturbance

[IEV 161-01-20]

3.14

port

particular interface of the EUT with the external electromagnetic environment

3.15

rise time

interval of time between the instants at which the instantaneous value of a pulse first reaches 10 % value and then the 90 % value

[IEV 161-02-05, modified]

3.16

transient

pertaining to or designating a phenomenon or a quantity which varies between two consecutive steady states during a time interval which is short compared with the time-scale of interest

[IEV 161-02-01]

3.17

verification

set of operations which is used to check the test equipment system (e.g. the test generator and the interconnecting cables) and to demonstrate that the test system is functioning within the specifications given in Clause 6

NOTE 1 The methods used for verification may be different from those used for calibration.

NOTE 2 The procedure of 6.1.2 and 6.2.2 is meant as a guide to insure the correct operation of the test generator, and other items making up the test set-up so that the intended waveform is delivered to the EUT.

NOTE 3 For the purpose of this basic EMC standard this definition is different from the definition given in IEV 311-01-13.

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4 General

The repetitive fast transient test is a test with bursts consisting of a number of fast transients, coupled into power supply, control, signal and earth ports of electrical and electronic equipment. Significant for the test are the high amplitude, the short rise time, the high repetition rate, and the low energy of the transients.

The test is intended to demonstrate the immunity of electrical and electronic equipment when subjected to types of transient disturbances such as those originating from switching transients (interruption of inductive loads, relay contact bounce, etc.).

5 Test levels

The preferred test levels for the electrical fast transient test, applicable to power, ground, signal and control ports of the equipment are given in Table 1.

Table 1 - Test levels

	Open circuit output test voltage and repet On power port, PE		On I/O (input/output) signal, data and control ports	
Level	Voltage peak	Repetition rate	Voltage peak	Repetition rate
	kV	kHz	kV	kHz
1	0,5	5 or 100	0,25	5 or 100
2	1	5 or 100	0,5	5 or 100
3	2	5 or 100	1	5 or 100
4	4	5 or 100	2	5 or 100
x ^a	Special	Special	Special	Special

NOTE 1 Use of 5 kHz repetition rates is traditional; however, 100 kHz is closer to reality. Product committees should determine which frequencies are relevant for specific products or product types.

NOTE 2 With some products, there may be no clear distinction between power ports and I/O ports, in which case it is up to product committees to make this determination for test purposes.

These open-circuit output voltages will be displayed on the EFT/B generator. For selection of levels, see Annex B.

6 Test equipment

The verification procedures of 6.1.2 and 6.2.2 are meant as a guide to insure the correct operation of the test generator, coupling/decoupling networks, and other items making up the test set-up so that the intended waveform is delivered to the EUT.

a "X" is an open level. The level has to be specified in the dedicated equipment specification.

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6.1 Burst generator

The simplified circuit diagram of the generator is given in Figure 1. The circuit elements $C_{\rm c}$, $R_{\rm s}$, $R_{\rm m}$, and $C_{\rm d}$ are selected so that the generator delivers a fast transient under open circuit conditions and with a 50 Ω resistive load. The effective output impedance of the generator shall be 50 Ω .

The major elements of the test generator are:

- high-voltage source;
- charging resistor;
- energy storage capacitor;
- high voltage switch;
- impulse duration shaping resistor;
- impedance matching resistor;
- d.c. blocking capacitor.

6.1.1 Characteristics of the fast transient/burst generator

The characteristics of the fast transient/burst generator are the following:

- Output voltage range with 1 000 Ω load shall be at least 0,25 kV to 4 kV
- Output voltage range with 50 Ω load shall be at least 0,125 kV to 2 kV

The generator shall be capable of operating under short-circuit conditions.

Characteristics:

polarity:		positive/negative
 output typ 	e:	coaxial, 50 Ω
 d.c. blocki 	ing capacitor	10 nF \pm 20 $\%$

- repetition frequency: (see Table 2) \pm 20 %

relation to power supply: asynchronous

- burst duration: 15 ms \pm 20 % at 5 kHz (see Figure 2) 0,75 ms \pm 20 % at 100 kHz

- burst period: 300 ms \pm 20 %

(see Figure 2)

wave shape of the pulse

• into 50 Ω load rise time t_r = 5 ns ± 30 %

duration t_{d} (to 50 %) = 50 ns ± 30 %

peak voltage = according to Table 2, ±10 %

(see Figure 3 for the 50 Ω waveshape)

• into 1 000 Ω load rise time t_r = 5 ns ± 30 %

duration $t_{\rm d}$ (to 50 %) = 50 ns with a tolerance of

-15 ns to +100 ns

peak voltage = according to Table 2, ±20%

(see Note 2 below Table 2)

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- test load impedance

50 Ω ± 2 %

1 000 Ω ± 2 % in parallel with \leq 6 pF. The resistance measurement is made at d.c. and the capacitance measurement is made using a commercially available capacitance meter that operates at low frequencies.

6.1.2 Verification of the characteristics of the fast transient/burst generator

The test generator characteristics shall be verified in order to establish a common reference for all generators. For this purpose, the following procedure shall be undertaken.

The test generator output shall be connected to a 50 Ω and 1 000 Ω coaxial termination respectively and the voltage monitored with an oscilloscope. The -3 dB bandwidth of the measuring equipment and the test load impedance shall be at least 400 MHz. The test load impedance at 1 000 Ω is likely to become a complex network. The rise time, impulse duration and repetition rate of the impulses within one burst shall be monitored as well as the burst duration and burst period.

For each of the set voltages of Table 2, measure the output voltage at a 50 Ω load $[V_{\rm D}$ (50 Ω)]. This measured voltage shall be $[0.5 \times V_{\rm D}$ (open circuit)] \pm 10%.

With the same generator setting (set voltage), measure the voltage at a 1 000 Ω load – $[V_p (1\ 000\ \Omega)]$. This measured voltage shall be V_p (open circuit) $\pm\ 20\%$.

NOTE 1 Measures should be taken to ensure that stray capacitance is kept to a minimum.

Table 2 - Output voltage peak values and repetition rates

Set voltage	V _p (open circuit) k∨	V _p (1 000 Ω)	V _p (50 Ω)	Repetition frequency
				kHz
0,25	0,25	0,24	0,125	5 or 100
0,5	0,5	0,48	0,25	5 or 100
1	1	0,95	0,5	5 or 100
2	2	1,9	1	5 or 100
4	4	3,8	2	5 or 100

NOTE 2 Use of a 1 000 Ω load resistor will automatically result in a voltage reading that is 5 % lower than the set voltage as shown in column V_p (1 000 Ω). The reading V_p at 1000 Ω = V_p (open circuit) multiplied times 1000/1050 (the ratio of the test load to the total circuit impedance of 1000 Ω plus 50 Ω).

NOTE 3 With the 50 Ω load, the measured output voltage is 0,5 times the value of the unloaded voltage as reflected in the table above.

6.2 Coupling/decoupling network for a.c./d.c. mains supply port

The coupling/decoupling network is required for acceptance tests of a.c./d.c. power supply ports.

The circuit diagram (example for a three-phase power mains supply) is given in Figure 4.

The waveform of the EFT/B generator shall be verified at the output of the coupling network according to 6.2.2.

6.2.1 Characteristics of the coupling/decoupling network

The characteristics of the coupling/decoupling network are the following:

coupling capacitors:33 nF;

coupling mode: common mode.

6.2.2 Verification of the characteristics of the coupling/decoupling network

The requirements given in 6.1.2 also apply to the measurement equipment that is used for the verification of the characteristics of the coupling/decoupling network.

The waveform shall be individually verified for each coupling line at each output terminal (L1, L2, L3, N and PE) of the coupling/decoupling network with a single 50 Ω termination to reference ground. Figure 14 shows one of the five verification measurements; the verification measurement of L1 to reference ground.

NOTE Verifying each coupling line separately is done to ensure that each line is properly functioning and calibrated.

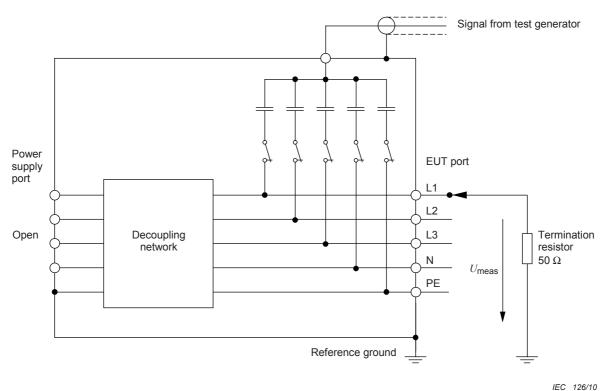


Figure 14 – Verification of the waveform at the output of the coupling/decoupling network

The verification is performed with the generator output at a set voltage of 4 kV. The generator is connected to the input of the coupling/decoupling network. The individual outputs of the CDN (normally connected to the EUT) are terminated with a 50 Ω load while the other outputs are open. The peak voltage and waveform are recorded.

Rise time of the pulses (10 % to 90 % value) shall be 5 ns \pm 1,5 ns.

Impulse duration (50 % value) shall be 50 ns \pm 15 ns.

Peak voltage shall be 2 kV \pm 0,2 kV according to Table 2.

The residual test pulse voltage on the inputs of the coupling/decoupling network when the EUT and the power network are disconnected shall not exceed 10 % of the applied test voltage.

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6.3 Capacitive coupling clamp

The clamp provides the ability of coupling the fast transients/bursts to the circuit under test without any galvanic connection to the terminals of the EUT's ports, shielding of the cables or any other part of the EUT.

The coupling capacitance of the clamp depends on the cable diameter, material of the cables, and cable shielding (if any).

The device is composed of a clamp unit (made, for example, of galvanized steel, brass, copper or aluminium) for housing the cables (flat or round) of the circuits under test and shall be placed on a ground reference plane of minimum area of 1 m^2 . The ground (reference) plane shall extend beyond the clamp by a least 0,1 m on all sides.

The clamp shall be provided at both ends with a high-voltage coaxial connector for the connection of the test generator at either end. The generator shall be connected to that end of the clamp which is nearest to the EUT.

The clamp itself shall be closed as much as possible to provide maximum coupling capacitance between the cable and the clamp.

The mechanical arrangement of the coupling clamp is given in Figure 5 and determines its characteristics, such as frequency response, impedance, etc.

Characteristics:

typical coupling capacitance between cable and clamp: 100 pF to 1 000 pF;

usable diameter range of round cables: 4 mm to 40 mm;

insulation withstand capability: 5 kV (test pulse: 1,2/50 μs).

The coupling method using the clamp is required for acceptance tests on lines connected to I/O and communication ports. It may also be used on ac/dc power supply ports only if the coupling/decoupling network defined in 6.2 cannot be used.

7 Test set-up

Different types of tests are defined based on test environments. These are:

- type (conformance) tests performed in laboratories;
- post-installation tests performed on equipment in its final installed conditions.

The preferred test method is that of type tests performed in laboratories.

The EUT shall be arranged in accordance with the manufacturer's instructions for installation (if any).

7.1 Test equipment

The test set-up includes the following equipment (see Figure 6):

- ground reference plane;
- coupling device (network or clamp);
- decoupling network;
- test generator.

7.2 Test set-up for type tests performed in laboratories

7.2.1 Test conditions

The following requirements apply to tests performed in laboratories with the environmental reference conditions specified in 8.1.

EUTs, whether stationary floor-mounted or table top, and equipment designed to be mounted in other configurations, shall be placed on a ground reference plane and shall be insulated from it by an insulating support $0.1 \text{ m} \pm 0.01 \text{ m}$ thick (see Figure 7).

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In the case of table-top equipment, the EUT should be located 0,1 m \pm 0,01 m above the ground reference plane (see Figure 7). Equipment normally mounted on ceilings or walls shall be tested as table-top equipment with the EUT located 0,1m \pm 0,01 m above the ground reference plane.

The test generator and the coupling/decoupling network shall be placed directly on, and bonded to, the ground reference plane.

The ground reference plane shall be a metallic sheet (copper or aluminium) of 0,25 mm minimum thickness; other metallic materials may be used but they shall have 0,65 mm minimum thickness.

The minimum area of the ground reference plane is 1 m \times 1 m. The actual size depends on the dimensions of the EUT.

The ground reference plane shall project beyond the EUT by at least 0,1 m on all sides.

The ground reference plane shall be connected to the protective earth.

The EUT shall be arranged and connected to satisfy its functional requirements, according to the equipment installation specifications.

The minimum distance between the EUT and all other conductive structures (e.g. the walls of a shielded room), except the ground reference plane shall be more than 0,5 m.

All cables to the EUT shall be placed on the insulation support 0,1 m above the ground reference plane. Cables not subject to electrical fast transients shall be routed as far as possible from the cable under test to minimize the coupling between the cables.

The EUT shall be connected to the earthing system in accordance with the manufacturer's installation specifications; no additional earthing connections are allowed.

The connection impedance of the coupling/decoupling network earth cables to the ground reference plane and all bondings shall provide a low inductance.

Either a direct coupling network or a capacitive clamp shall be used for the application of the test voltages. The test voltages shall be coupled to all of the EUT ports including those between two units of equipment involved in the test, unless the length of the interconnecting cable makes it impossible to test.

Decoupling networks shall be used to protect auxiliary equipment and public networks.

When using the coupling clamp, the minimum distance between the coupling plates and all other conductive surfaces, except the ground reference plane beneath the coupling clamp, shall be 0,5 m.

Unless otherwise specified in the product standard or the product family standard, the length of the signal and power lines between the coupling device and the EUT shall be $0.5~\text{m} \pm 0.05~\text{m}$.

If the manufacturer provides a non-detachable supply cable more than $0.5 \text{ m} \pm 0.05 \text{ m}$ long with the equipment, the excess length of this cable shall be folded to avoid a flat coil and situated at a distance of 0.1 m above the ground reference plane.

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Examples of the test set-up for laboratory tests are given in Figures 7 and 8.

In Figure 8, an additional ground plane, connected to the chassis of the EUT is used.

7.2.2 Methods of coupling the test voltage to the EUT

The method of coupling the test voltage to the EUT is dependent on the type of EUT port (as indicated below).

7.2.2.1 Power supply ports

An example for the test set-up for direct coupling of the EFT/B disturbance voltage via a coupling/decoupling network is given in Figure 9. This is the preferred method of coupling to power supply ports.

If a suitable coupler/decoupler cannot be obtained, i.e. for a.c. mains currents >100 A, alternative methods can be employed; however, use of the capacitive clamp is discouraged since its efficiency in coupling the bursts is considerably less than direct injection using the 33 nF capacitors.

7.2.2.2 I/O and communication ports

The examples in Figures 7 and 10 show how to use the capacitive coupling clamp for application of the disturbance test voltage to I/O and communication ports. When using the capacitive coupling clamp, non-tested or auxiliary equipment connected should be appropriately decoupled.

7.2.2.3 Cabinet earth port

The test point on the cabinet shall be the terminal for the protective earth conductor.

The test voltage shall be applied to the protective earth (PE) connection through a 33 nF coupling capacitor according to Figure 11.

7.3 Test set-up for post-installation tests

These tests are optional. They may be applied only when agreed between manufacturer and customer. It has to be considered that the test itself may be destructive to the EUT and other co-located equipment may be damaged or otherwise unacceptably affected.

The equipment or system shall be tested in the final installed conditions. Post-installation tests shall be performed without coupling/decoupling networks in order to simulate the actual electromagnetic environment as closely as possible.

If equipment or system other than the EUT are unduly affected during the test procedure, decoupling networks shall be used by agreement between the user and the manufacturer.

7.3.1 Test on power supply ports and earth ports

7.3.1.1 Stationary, floor-mounted equipment

The test voltage shall be applied simultaneously between a ground reference plane and all of the power supply terminals, a.c. or d.c., and the protective or functional earth port on the EUT cabinet.

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For the test set-up, see Figure 11.

A ground reference plane of minimum area of 1 m^2 (as described in 7.2.1) shall be mounted near the EUT and connected to the protective earth conductor at the power supply mains outlet.

The EFT/B generator shall be located on the ground reference plane. The length of the "hot wire" from the coaxial output of the EFT/B-coupling device to the ports on the EUT shall be $0.5~\text{m} \pm 0.05~\text{m}$. This connection shall be unshielded but well insulated. If a.c./d.c. blocking capacitors are necessary, their capacitance shall be 33 nF. All other connections of the EUT should be in accordance with its functional requirements.

7.3.1.2 Non-stationary mounted EUT, connected to the mains supply by flexible cord and plugs

The test voltage shall be applied simultaneously between each of the power supply conductors and the protective earth at the power supply (see Figure 12).

7.3.2 Test on I/O and communication ports

The capacitive coupling clamp is the preferred method for coupling the test voltage into I/O and communication ports. However, if the clamp cannot be used due to mechanical problems (size, cable routing) in the cabling, it shall be replaced by a tape or a conductive foil enveloping the lines under test. The capacitance of this coupling arrangement with foil or tape should be equivalent to that of the standard coupling clamp.

An alternative method is to couple the EFT/B generator to the terminals of the lines via discrete 100 pF capacitors instead of the distributed capacitance of the clamp or of the foil or tape arrangement.

If an EUT contains many similar ports, the manufacturer can elect to test a representative number of cables as long as those are clearly identified.

Earthing of the coaxial cable from the test generator shall be made in the vicinity of the coupling point. Application of the test voltage to the connectors (hot wires) of coaxial or shielded communication lines is not permitted.

The test voltage should be applied in a way that the shielding protection of the equipment will not be reduced. See Figure 13 for the test configuration.

The test results obtained with the discrete capacitor coupling arrangement are likely to be different from those obtained with the coupling clamp or the foil coupling. Therefore, the test levels specified in Clause 5 may be amended by a product committee in a product standard in order to take significant installation characteristics into consideration.

In the post installation test it can be agreed between manufacturer and user that external cables can be tested by routing all cables simultaneously in the coupling clamp.

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8 Test procedure

The performance of the test equipment shall be checked prior to the test. This check can usually be limited to the existence of the burst for the generator at the output of the coupling device.

The test procedure includes:

- the verification of the laboratory reference conditions;
- the preliminary verification of the correct operation of the equipment;
- the execution of the test;
- the evaluation of the test results.

8.1 Laboratory reference conditions

In order to minimize the effect of environmental parameters on test results, the test shall be carried out in climatic and electromagnetic reference conditions as specified in 8.1.1 and 8.1.2.

8.1.1 Climatic conditions

Unless otherwise specified by the committee responsible for the generic or product standard, the climatic conditions in the laboratory shall be within any limits specified for the operation of the EUT and the test equipment by their respective manufacturers.

Tests shall not be performed if the relative humidity is so high as to cause condensation on the EUT or the test equipment.

NOTE Where it is considered that there is sufficient evidence to demonstrate that the effects of the phenomenon covered by this standard are influenced by climatic conditions, this should be brought to the attention of the committee responsible for this standard.

8.1.2 Electromagnetic conditions

The electromagnetic conditions of the laboratory shall be such to guarantee the correct operation of the EUT in order not to influence the test results.

8.2 Execution of the test

The test shall be carried out on the basis of a test plan that shall include the verification of the performances of the EUT as defined in the technical specification.

The EUT shall be in the normal operating conditions.

The test plan shall specify:

- type of test that will be carried out;
- test level;
- polarity of the test voltage (both polarities are mandatory);
- internal or external generator;
- duration of the test not less than 1 min (1 min has been chosen in order to speed up the
 test; however, to avoid synchronization, the test time may be broken down into six 10 s
 bursts separated by a 10 s pause. In the real environment, bursts will occur randomly as
 single events. It is not intended that the burst be synchronized with EUT signals. Product
 committees may choose other test durations.)

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- number of applications of the test voltage;
- EUT's ports to be tested;
- representative operating conditions of the EUT;
- sequence of application of the test voltage to the EUT's ports, each one after the other or to cables belonging to more than one circuit, etc.;
- auxiliary equipment.

9 Evaluation of test results

The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test, relative to a performance level defined by its manufacturer or the requestor of the test, or agreed between the manufacturer and the purchaser of the product. The recommended classification is as follows:

- a) normal performance within limits specified by the manufacturer, requestor or purchaser;
- b) temporary loss of function or degradation of performance which ceases after the disturbance ceases, and from which the equipment under test recovers its normal performance, without operator intervention;
- c) temporary loss of function or degradation of performance, the correction of which requires operator intervention;
- d) loss of function or degradation of performance which is not recoverable, owing to damage to hardware or software, or loss of data.

The manufacturer's specification may define effects on the EUT which may be considered insignificant, and therefore acceptable.

This classification may be used as a guide in formulating performance criteria, by committees responsible for generic, product and product-family standards, or as a framework for the agreement on performance criteria between the manufacturer and the purchaser, for example where no suitable generic, product or product-family standard exists.

10 Test report

The test report shall contain all the information necessary to reproduce the test. In particular, the following shall be recorded:

- the items specified in the test plan required by Clause 8 of this standard;
- identification of the EUT and any associated equipment, e.g. brand name, product type, serial number;
- identification of the test equipment, e.g. brand name, product type, serial number;
- any special environmental conditions in which the test was performed, e.g. shielded enclosure;
- any specific conditions necessary to enable the test to be performed;
- performance level defined by the manufacturer, requestor or purchaser;
- performance criterion specified in the generic, product or product-family standard;
- any effects on the EUT observed during or after the application of the test disturbance, and the duration for which these effects persist;

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 the rationale for the pass/fail decision (based on the performance criterion specified in the generic, product or product-family standard, or agreed between the manufacturer and the purchaser);

 any specific conditions of use, for example cable length or type, shielding or grounding, or EUT operating conditions, which are required to achieve compliance.

Concerning measurement uncertainty, it is sufficient to state that the test equipment meets the tolerance requirements of IEC 61000-4-4; however, when checking for compliance with the specified tolerances, the calibration uncertainty is to be taken into account.

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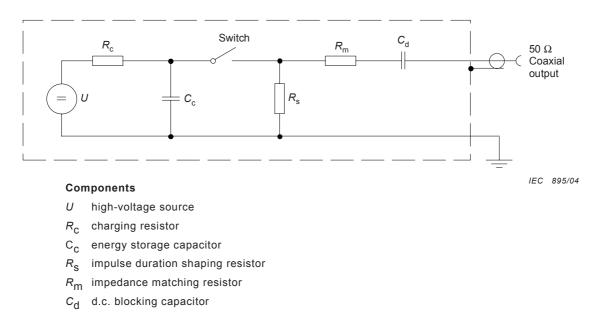


Figure 1 - Simplified circuit diagram of a fast transient/burst generator

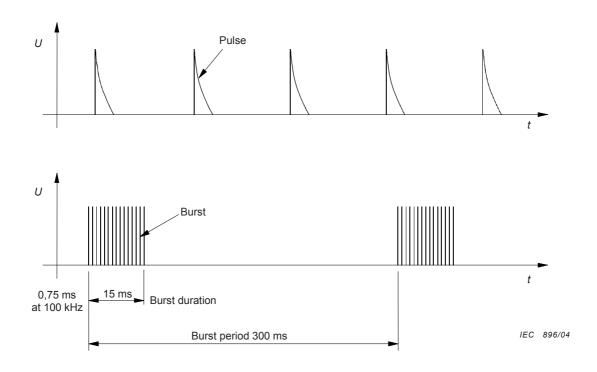


Figure 2 - General graph of a fast transient/burst

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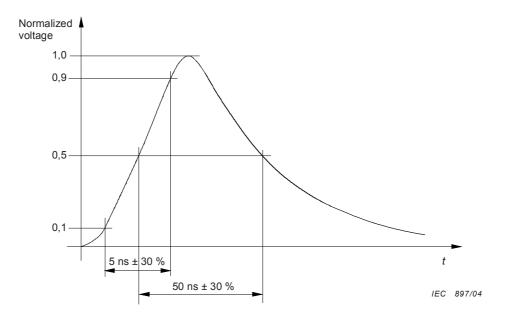
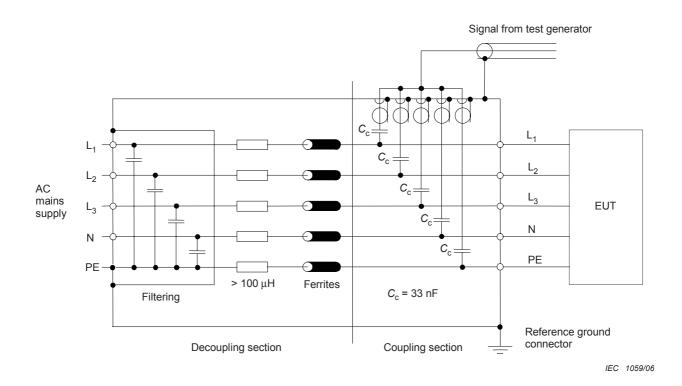


Figure 3 – Waveshape of a single pulse into a 50 Ω load



Components

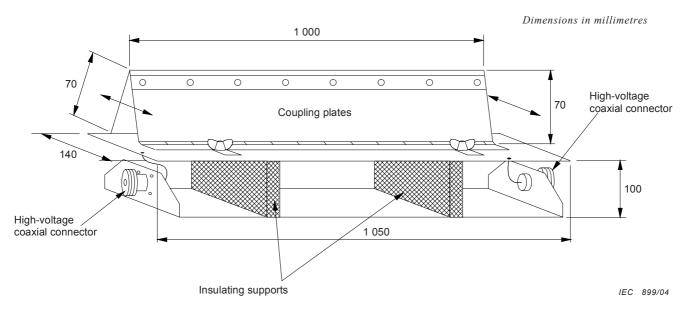
 L_1, L_2, L_3 , phases

N neutral

PE protective earth C_c coupling capacitor

Figure 4 - Coupling/decoupling network for a.c./d.c. power mains supply ports/terminals

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Warning The distance of the coupling section to all other conductive constructions except to the cable under test and the ground plane shall be more than 0,5 m.

Figure 5 - Construction of the capacitive coupling clamp

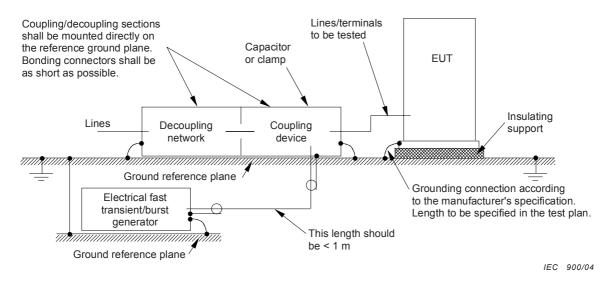
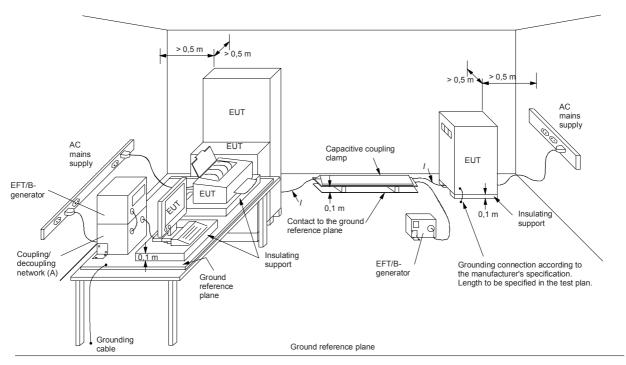


Figure 6 – Block diagram for electrical fast transient/burst immunity test

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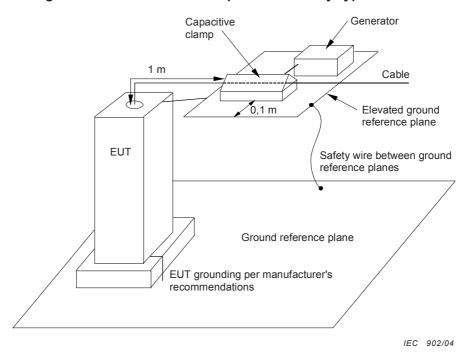
EN 61000-4-4:2004+A1:2010



IEC 901/04 Key

- length between clamp and the EUT to be tested (should be $0.5 \text{ m} \pm 0.05 \text{ m}$)
- location for supply line coupling
- location for signal lines coupling

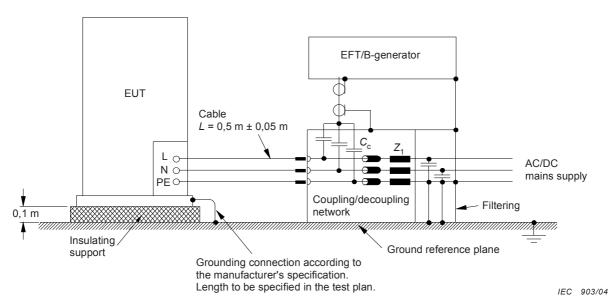
Figure 7 - General test set-up for laboratory type tests



NOTE The clamp may be mounted on the wall of a shielded room or any other grounded surface and bonded to the EUT. For large, floor standing systems with cables exiting at the top, the clamp could also be centred 10 cm above the EUT and have cables drop through the centre of the plane.

Figure 8 - Example of a test set-up for rack mounted equipment

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Components

PE protective earth

N neutral

L phase

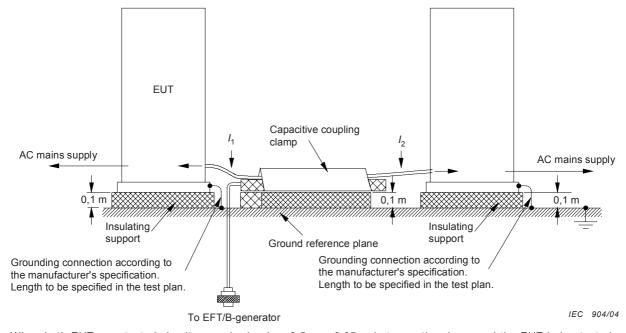
Z₁ decoupling inductive

c coupling capacitor

NOTE 1 DC terminals can be treated in a similar way.

NOTE 2 Signal and power cables between the CDN and EUT can be up to 1 m in length if so specified in product or product family standards.

Figure 9 – Example of a test set-up for direct coupling of the test voltage to a a.c./d.c. power supply ports/terminal for laboratory purposes



When both EUTs are tested simultaneously: $I_1 = I_2 = 0.5 \text{ m} \pm 0.05 \text{ m}$ between the clamp and the EUT being tested. When only one EUT is tested, a decoupling network must be inserted between the capacitive coupling and the non-tested EUT.

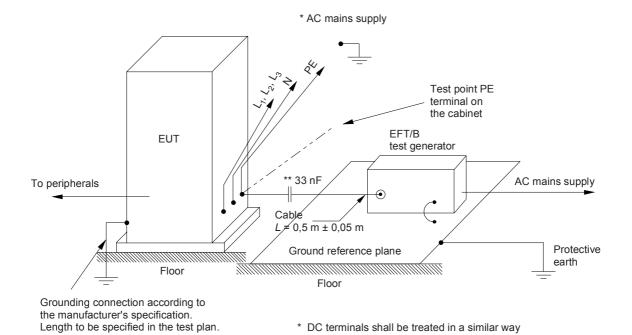
NOTE The EFT/B generator must be bonded to the ground reference plane.

Figure 10 – Example of test set-up for application of the test voltage by the capacitive coupling clamp for laboratory test purposes

 $\begin{array}{c} {\rm Page}\ 25 \\ {\rm BS}\ {\rm EN}\ 61000\text{--}4\text{--}4\text{:}2004\text{+-}A1\text{:}2010 \end{array}$

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IEC 905/04



Components

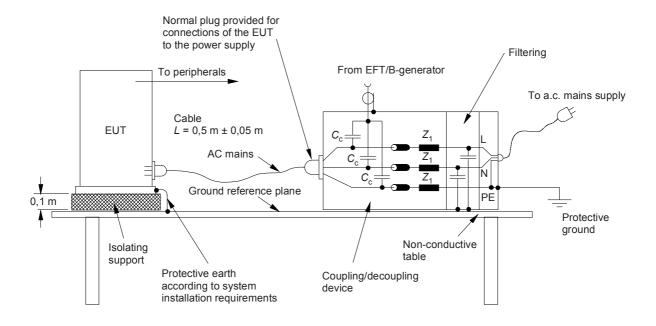
PE protective earth

N neutral L1, L2, L3 phases

Figure 11 – Example for post-installation test on a.c./d.c. power supply ports and protective earth terminals for stationary, floor-mounted EUT

** Blocking capacitors if necessary

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Components IEC 906/04

 $C_{\rm c}$ coupling capacitors = 33 nF

 Z_1 decoupling inductor >100 μ H

L phase

N neutral

PE protective earth

NOTE Signal and power cables can be up to 1 m in length if so specified in product or product family standards.

Figure 12 – Example for post-installation test on a.c. mains supply port and protective earth terminals for non-stationary mounted EUT

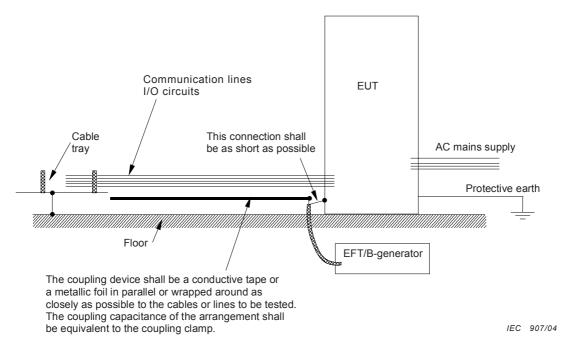


Figure 13 – Example of post-installation test on communications and I/O ports without the capacitive coupling clamp

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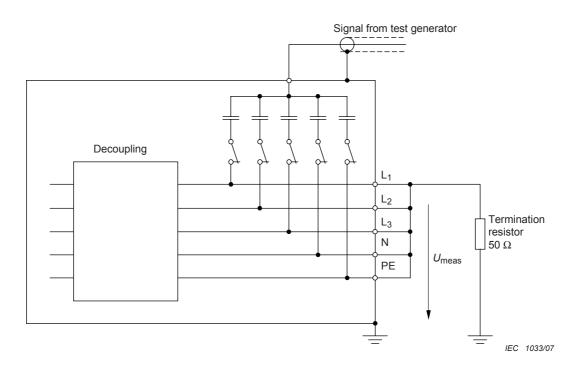


Figure 14 - Verification of the waveform at the common mode output of the coupling/decoupling network

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Annex A (informative)

Information on the electrical fast transients

A.1 Introduction

The electrical fast transient burst (EFT) is generated by the switching of inductive loads. This switching transient is commonly referred to as fast transient and may be described in terms of:

- the duration of the burst which is predominately determined by the energy stored in the inductance prior to switching;
- the repetition rate of the individual transients;
- the varying amplitude of the transients composing a burst determined mainly by the mechanical and electrical characteristics of the switching contact (speed of the contacts in the opening operation, voltage withstand capability of the contacts in their open condition).

Generally, the EFT has no unique parameters that depend upon the characteristics of the switching contact or the switched load.

A.2 Spike amplitude

The level of the spikes measured on the conductors of a line may have the same value as galvanic connection of this line with the switching contact. In the case of the power supply and some control circuits, this may also be true in the proximity (distance of the order of 1 m) of the contacts. In this case, the disturbance is transferred by induction (e.g. capacitive). The amplitude is a fraction of the level measured at the contacts.

A.3 Rise time

It should be noted however that as the distance from the source increases, the waveform is modified due to propagation losses, dispersion, and reflections due to distortions caused by the connected loads. The rise time of 5 ns assumed for the specifications of the test generator is a compromise that takes into account the effect of the attenuation of the high frequency components in the spike propagation.

A shorter rise time, e.g. 1 ns, would give more conservative test results, and its appropriateness is mainly related to equipment having short connections in the field with reference to the EFT source.

NOTE The actual rise time of the EFT at the source, for voltage range 500 V to 4 kV and more, is very close to the rise time of an electrostatic discharge (in air) – the discharge mechanism being the same.

A.4 Spike duration

The actual duration differs significantly from that specified in the first edition as well in this second edition of the standard. It is however consistent with the duration of the spikes measured as induced voltages in the victim circuits due to less relevance of the low frequency components of the spikes.

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A.5 Spike repetition rate

The repetition rate depends on many parameters. For example:

- time constant of the charging circuit (resistance, inductance and distributed capacity of the switched inductive load);
- time constant of the switching circuit, including the impedance of the line connecting this load to the switching contact;
- speed of the contact in the opening action;
- withstanding voltage of the switching contact.

The repetition rate is therefore variable, and the range of one decade or more is quite common.

NOTE In practice, the repetition rate of 100 kHz could have been selected for testing as the compromise repetition rate because of the need to include in one test the range of the most significant parameters of the EFT/B.

A.6 Number of spikes/burst and burst duration

This (these) parameter(s) depends on the energy stored by the switched inductive load as well as the withstand voltage of the switching contact.

The number of spikes/burst is directly related to the spike repetition rate and burst duration. From measured results, most of the duration of bursts are very near to 2 ms, with the exception of the mercury wetted relay, the use of which is not as common as for the other types considered here.

NOTE The 0,75 ms duration was chosen as the reference time for testing at 100 kHz. Accordingly, 75 is the resultant number of spikes/burst.

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Annex B (informative)

Selection of the test levels

The test levels should be selected in accordance with the most realistic installation and environmental conditions. These levels are outlined in Clause 5 of this standard.

The immunity tests are correlated with these levels in order to establish a performance level for the environment in which the equipment is expected to operate.

For testing I/O, control, signal and data EUT ports, use half the test voltage values applied on power supply.

Based on common installation practices, the recommended selection of test levels for EFT/B testing according to the requirements of the electromagnetic environment, is the following:

a) Level 1: Well-protected environment

The installation is characterized by the following attributes:

- suppression of all EFT/B in the switched power supply and control circuits;
- separation between power supply lines (a.c. and d.c.) and control and measurement circuits coming from other environments belonging to higher severity levels:
- shielded power supply cables with the screens earthed at both ends on the reference ground of the installation, and power supply protection by filtering.

The computer room may be representative of this environment.

The applicability of this level to testing of equipment is limited to the power supply circuits for type tests, and to the earthing circuits and equipment cabinets for post-installation tests.

b) Level 2: Protected environment

The installation is characterized by the following attributes:

- partial suppression of EFT/B in the power supply and control circuits which are switched only by relays (no contactors);
- poor separation of the industrial circuits belonging to the industrial environment from other circuits associated with environments of higher severity levels;
- physical separation of unshielded power supply and control cables from signal and communication cables.

The control room or terminal room of industrial and electrical plants may be representative of this environment.

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c) Level 3: Typical industrial environment

The installation is characterized by the following attributes:

- no suppression of EFT/B in the power supply and control circuits which are switched only by relays (no contactors);
- poor separation of the industrial circuits from other circuits associated with environments of higher severity levels;
- dedicated cables for power supply, control, signal and communication lines;
- poor separation between power supply, control, signal and communication cables;
- availability of earthing system represented by conductive pipes, earth conductors in the cable trays (connected to the protective earth system) and by a ground mesh.

The area of industrial process equipment may be representative of this environment.

d) Level 4: Severe industrial environment

The installation is characterized by the following attributes:

- no suppression of EFT/B in the power supply and control and power circuits which are switched by relays and contactors;
- no separation of the industrial circuits belonging to the severe industrial environment from other circuits associated with environments of higher severity levels;
- no separation between power supply, control, signal and communication cables;
- use of multicore cables in common for control and signal lines.

The outdoor area of industrial process equipment where no specific installation practice has been adopted, power plants, the relay rooms of open-air H.V. substations and gas insulated substations of up to 500 kV operating voltage (with typical installation practice) may be representative of this environment.

e) Level 5: Special situations to be analysed

The minor or major electromagnetic separation of disturbance sources from equipment circuits, cables, lines etc., and the quality of the installations may require the use of a higher or lower environmental level than those described above. It should be noted that equipment lines of a higher environmental level can penetrate a lower severity environment.

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Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE Where an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	EN/HD	<u>Year</u>
IEC 60050-161	1990	International Electrotechnical Vocabulary (IEV) Chapter 161: Electromagnetic compatibility	-	-

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Bibliography

IEC 60050-300:2001, International Electrotechnical Vocabulary (IEV) – Electrical and electronic measurements and measuring instruments – Part 311: General terms relating to measurements – Part 312: General terms relating to electrical measurements – Part 313: Types of electrical measuring instruments – Part 314: Specific terms according to the type of instrument

IEC 61000-4-4:1995, Electromagnetic compatibility (EMC) – Part 4: Testing and measurement techniques – Section 4: Electrical fast transient/burst immunity test

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